Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,787	BUCHNER ET AL.
Examiner	Art Unit
Aung T. Win	2617

	SEARCHED		
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	1		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
searched by keywords	12/4/2006	ATW
discussed with Tommy Chin and John Peng for claims clarity	12/4/2006	ATW